

**Search Notes**

Application/Control No.

10/672,096

Examiner

John Chavis

Applicant(s)/Patent under  
Reexamination

YOON, YOUNG-JUN

Art Unit

2193

**SEARCHED**

Class	Subclass	Date	Examiner
717	108	2/15/2007	JC
709	316	2/15/2007	JC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
West (IBM TDB, DERWENT, EPO, JPO, USPAT, PGPUBS) anded with word search	2/15/2007	JC